


<b>Search Notes</b>  	<b>Application/Control No.</b>  10737139	<b>Applicant(s)/Patent Under Reexamination</b>  HASWELL, JONATHAN
	<b>Examiner</b>  BENJAMIN E LANIER	<b>Art Unit</b>  2132

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
East Search (See Attachment)	5/5/2008	BL

INTERFERENCE SEARCH			
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